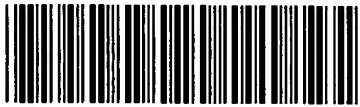


<b>Search Notes</b>  	<b>Application/Control No.</b>  10045467	<b>Applicant(s)/Patent Under Reexamination</b>  CHAN ET AL.
	<b>Examiner</b>  Jorgensen, Leland R	<b>Art Unit</b>  2675

SEARCHED			
Class	Subclass	Date	Examiner
349	151		
349	33		
349	121, 128-130		
349	139		
345	93. 94		
345	99-103		
349	141-143		
345	87-103, 204	9/11/07	LL

SEARCH NOTES			
Search Notes		Date	Examiner
East Search		9/11/07	LL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner